

**Search Notes**

Application/Control No.

10/531,456

Examiner

Helen C. Kwok

Applicant(s)/Patent under  
Reexamination

NICU ET AL.

Art Unit

2856

**SEARCHED**

Class	Subclass	Date	Examiner
73	504.02	6/16/2006	HK
73	504.04	6/16/2006	HK
73	504.12	6/16/2006	HK
73	504.16	6/16/2006	HK
73	504.14	6/16/2006	HK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR